


<b>Search Notes</b> 	<b>Application/Control No.</b> 10586482	<b>Applicant(s)/Patent Under Reexamination</b> ISHIKAWA ET AL.
	<b>Examiner</b> José V Chen	<b>Art Unit</b> 3637

SEARCHED			
Class	Subclass	Date	Examiner
108	22, 20, 21, 143, 94	05/26/09	jvc
74	16, 825, 813r		
248	349.1		

SEARCH NOTES			
Search Notes		Date	Examiner
for and back cit for pert art		05/26/09	jvc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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